

SEMICONDUCTOR TECHNICAL DATA

1N4148

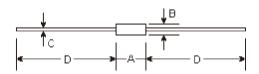
Features

Silicon Epitaxial Planar Diodes

fast switching diode.

This diode is also available in MiniMELF case with the type designation LL4148.

DO-35



DIMENSIONS									
DIM	inches		mm		Note				
	Min.	Max.	Min.	Max.	Note				
Α	-	0.154	-	3.9					
В	-	0.075	-	1.9	ф				
С	-	0.020	-	0.52	ф				
D	1.083	-	27.50	-					

Absolute Maximum Ratings $(T_a=25^{\circ}C)$

	Symbols	Values	Units	
Reverse Voltage	V _R	75	Volts	
Peak reverse voltage	V _{RM}	100	Volts	
Rectified current (Average) Half wave rectification with Resist. Load at T _{amb} =25 °Cand f≥50Hz	I _o	150 ¹⁾	mA	
Surge forward current at t<1s and $T_{j}\!=\!25^{\circ}\!\mathrm{C}$	I _{FSM}	500	mA	
Power dissipation at $T_{\mbox{\tiny amb}}$ =25 $^{\circ}{\mbox{\tiny C}}$	P _{tot}	500 ¹⁾	mW	
Junction Temperature	T _j	200 ℃		
Storage temperature range	T _s	-65 to +200	°C	

Note:

(1) Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature

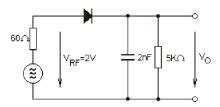
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Characteristics at T,=25℃

	Symbols	Min.	Тур.	Max.	Units
Forward voltage at I _F =10mA	V _F	-	-	1	Volt
Leakage current at V,=20V at V R -75V at V R -20V, T,=150 $^{\circ}$ C	R R R	- - -	- - -	25 5 50	nA uA uA
Reverse breakdown voltage tested wiht 100uA pulses	V _{(BR)R}	100	-	-	Volts
Capacitance at $V_F = V_R = 0$	C _{tot}	-	-	4	ρF
Voltage rise when switching ON tested with 50mA forward pulses t_p =0.1uS, rise time<30nS, t_p =5 to 100KHz	V _{fr}	-	-	2.5	Volts
Reverse recovery time from I_=10mA to I_=1mA, V_R =6V, R_L =100 Ω	t _{rr}	-	-	4	nS
Thermal resistance junction to ambient Air	R _{thA}	-	-	0.35 1)	K/mW
Rectification efficiency at f=100MHz, $V_{\rm RF}$ =2V	ην	0.45	-	-	-

Notes

Revision No: 0



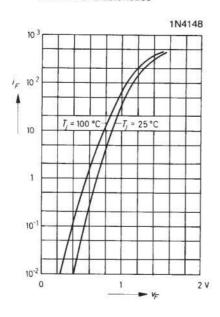
Rectification efficiency measurement circuit

⁽¹⁾ Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature



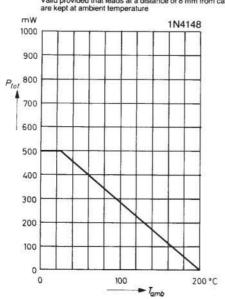
RATINGS AND CHARACTERISTIC CURVES

Forward characteristics

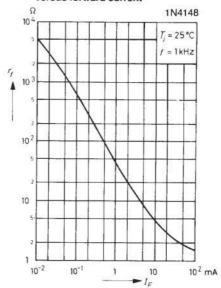


Admissible power dissipation versus ambient temperature

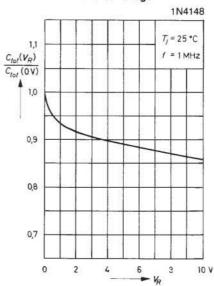
Valid provided that leads at a distance of 8 mm from case



Dynamic forward resistance versus forward current

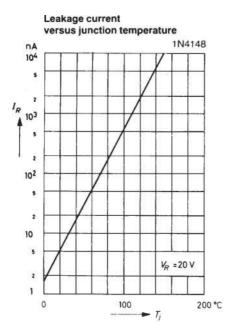


Relative capacitance versus reverse voltage





RATINGS AND CHARACTERISTIC CURVES



Admissible repetitive peak forward current versus pulse duration

Valid provided that leads at a distance of 8 mm from case are kept at ambient temperature

